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| Notice of References Cited | Application/Control No. 09/856,457 | Applicant(s)/Patent Under Reexamination KONISHI ET AL. | |
| | Examiner Alicia Chevalier | Art Unit 1772 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,396,634 | 05-2002 | Ishikawa et al. | 359/599 |
| | B | US-6,155,692 | 12-2000 | Ohkawa, Shingo | 362/31 |
| | C | US-6,151,169 | 11-2000 | Kim, Wook Sung | 359/640 |
| | D | US-5,727,107 | 03-1998 | Umemoto et al. | 385/116 |
| | E | US-5,575,549 | 11-1996 | Ishikawa et al. | 362/31 |
| | F | US-5,516,456 | 05-1996 | Shinohara et al. | 252/299.01 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
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